

10-Bit D-type flip-flop; positive-edge trigger; 3-state**74LVC821****FEATURES**

- Wide supply voltage range of 1.2 V to 3.6 V
- In accordance with JEDEC standard no. 8-1A.
- Inputs accept voltages upto 5.5 V
- CMOS low power consumption
- Direct Interface with TTL levels
- 8-bit positive edge-triggered register
- Independent register and 3-state buffer operation
- Flow-through pin-out architecture
- Output drive capability 50 Ω transmission lines @ 85 °C

DESCRIPTION

The 74LVC821 is a high-performance, low-power, low-voltage, Si-gate CMOS device and superior to most advanced CMOS compatible TTL families.

Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of these devices as translators in a mixed 3.3 V/5 V environment.

The 74LVC821 is a 10-bit D-type flip-flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus oriented applications. A clock (CP) and an output enable (\overline{OE}) input are common to all flip-flops.

The ten flip-flops will store the state of their individual D-inputs that meet the set-up and hold times requirements on the LOW-to-HIGH CP transition.

When \overline{OE} is LOW, the contents of the ten flip-flops is available at the outputs. When \overline{OE} is HIGH, the outputs go to the high impedance OFF-state. Operation of the \overline{OE} input does not affect the state of the flip-flops.

QUICK REFERENCE DATAGND = 0 V; $T_{amb} = 25$ °C; $t_i = t_l \leq 2.5$ ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t_{PHL}/t_{PLH}	propagation delay CP to Q_n	$C_L = 50$ pF $V_{cc} = 3.3$ V	4.8	ns
f_{max}	maximum clock frequency		150	MHz
C_i	input capacitance		5.0	pF
C_{PD}	power dissipation capacitance per flip-flop	notes 1 and 2	28	pF

Notes to the quick reference data

- C_{PD} is used to determine the dynamic power dissipation (P_D in μ W):

$$P_D = C_{PD} \times V_{cc}^2 \times f_i + \sum (C_L \times V_{cc}^2 \times f_o)$$
 where:
 f_i = input frequency in MHz; C_L = output load capacity in pF;
 f_o = output frequency in MHz; V_{cc} = supply voltage in V;
 $\sum (C_L \times V_{cc}^2 \times f_o)$ = sum of outputs.
- The condition is $V_i = GND$ to V_{cc} .

ORDERING INFORMATION

TYPE NUMBER	PACKAGES			
	PINS	PACKAGE	MATERIAL	CODE
74LVC821D	24	SO	plastic	SO24/SOT137
74LVC821DB	24	SSOP	plastic	SSOP24/SOT340
74LVC821PW	24	TSSOP	plastic	TSSOP24/SOT355

PINNING

PIN	SYMBOL	NAME AND FUNCTION
1	\overline{OE}	output enable input (active LOW)
2, 3, 4, 5, 6, 7, 8, 9, 10, 11	D_0 to D_9	data inputs
23, 22, 21, 20, 19, 18, 17, 16, 15, 14	Q_0 to Q_9	3-state flip-flop outputs
12	GND	ground (0 V)
13	CP	clock input (LOW-to-HIGH, edge-triggered)
24	V_{cc}	positive supply voltage

10-Bit D-type flip-flop; positive-edge trigger; 3-state

74LVC821

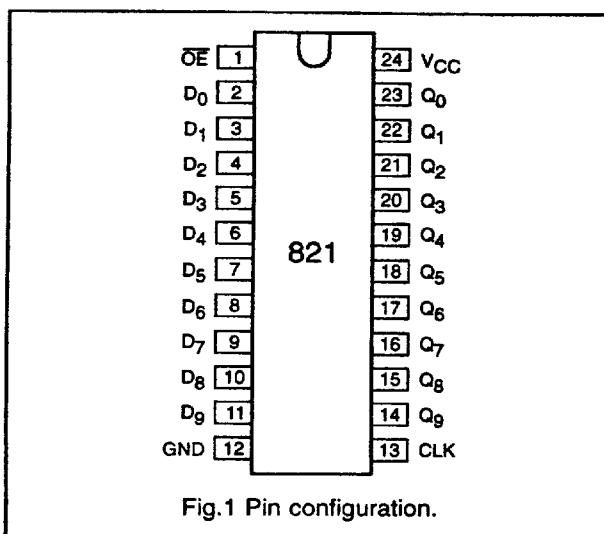


Fig.1 Pin configuration.

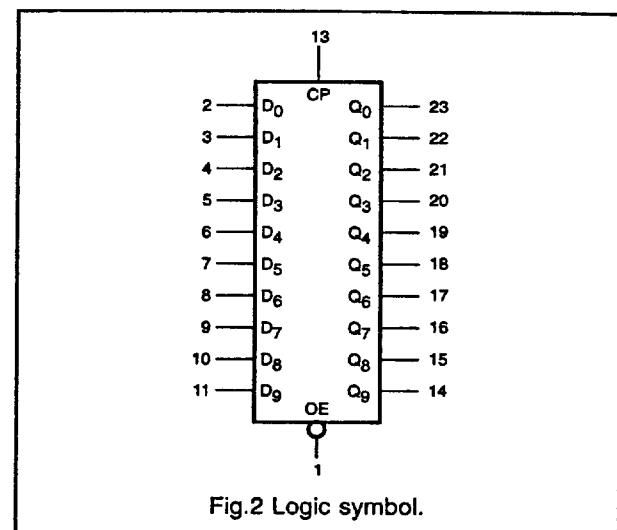


Fig.2 Logic symbol.

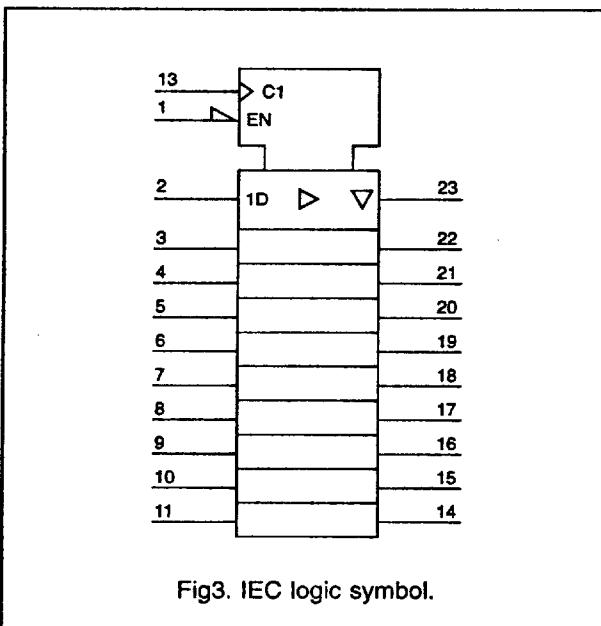


Fig.3. IEC logic symbol.

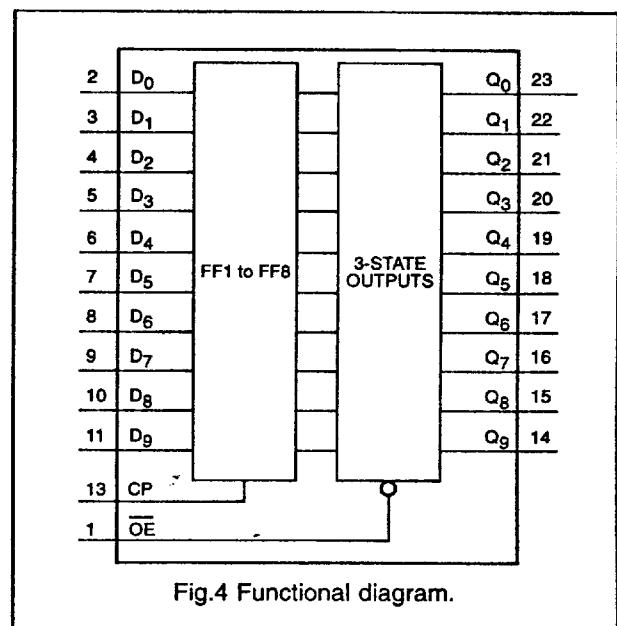


Fig.4 Functional diagram.

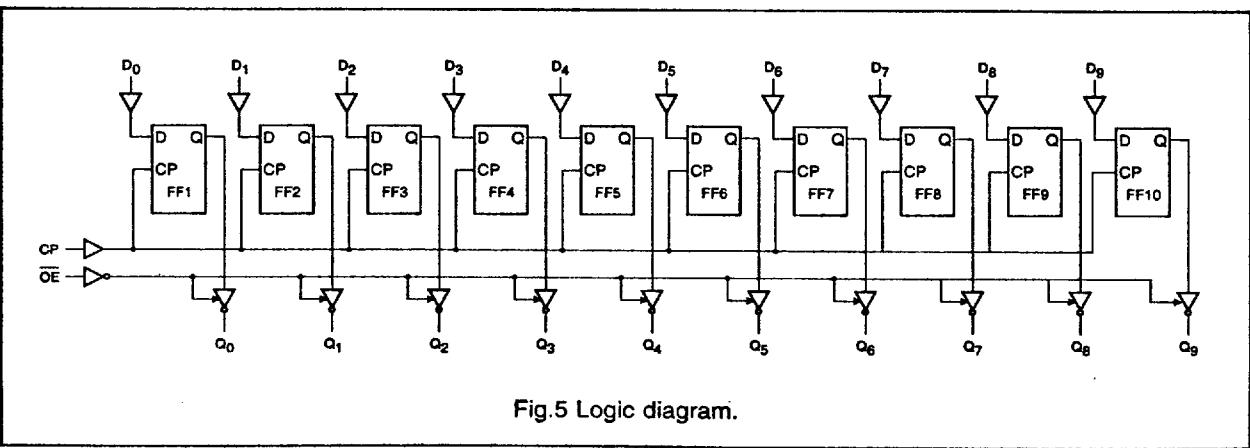


Fig.5 Logic diagram.

10-Bit D-type flip-flop; positive-edge trigger; 3-state

74LVC821

FUNCTION TABLE

OPERATING MODES	INPUTS			INTERNAL FLIP-FLOPS	OUTPUTS Q_0 to Q_9
	\overline{OE}	CP	D_n		
load and read register	L L	↑ ↑	I h	L H	L H
load register and disable outputs	H H	↑ ↑	I h	L H	Z Z
hold	L	H or L	X	NC	NC

H = HIGH voltage level

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH CP transition

L = LOW voltage level

I = LOW voltage level one set-up time prior to the LOW-to-HIGH CP transition

Z = high impedance OFF-state

↑ = LOW-to-HIGH clock transition

NC = no change

DC CHARACTERISTICS FOR 74LVC821

For the DC characteristics see chapter "LVC family characteristics", section "Family specifications".

AC CHARACTERISTICS FOR 74LVC821

GND = 0 V; $t_c = t_t \leq 2.5$ ns; $C_L = 50$ pF

SYMBOL	PARAMETER	T _{amb} (°C)			UNIT	TEST CONDITIONS		
		-40 to +85				V _{cc} (V)	WAVEFORMS	
		MIN.	TYP.	MAX.				
t_{PHL}/t_{PLH}	propagation delay CP to Q_n	- - -	- - -	8.0 7.0	ns	1.2 2.7 3.0 to 3.6	Fig.6	
t_{PZH}/t_{PZL}	3-state output enable time OE to Q_n	- - -	- - -	8.5 8.0	ns	1.2 2.7 3.0 to 3.6	Fig.7	
t_{PHZ}/t_{PLZ}	3-state output disable time OE to Q_n	- - -	- - -	- 7.5 7.0	ns	1.2 2.7 3.0 to 3.6	Fig.7	
t_w	clock pulse width HIGH or LOW	5.0 5.0	3.0 3.0*	-	ns	2.7 3.0 to 3.6	Fig.6	
t_{su}	set-up time D_n to CP	1.0 1.0	0.3 0.3*	-	ns	2.7 3.0 to 3.6	Fig.8	
t_h	hold time D_n to CP	1.0 1.0	-0.2 -0.2*	-	ns	2.7 3.0 to 3.6	Fig.8	
f_{max}	maximum clock pulse frequency	- 75	- 150*	-	MHz	2.7 3.0 to 3.6	Fig.6	

Notes: All typical values are measured at T_{amb} = 25 °C.* Typical values are measured at V_{cc} = 3.3 V.

10-Bit D-type flip-flop; positive-edge trigger; 3-state

74LVC821

AC WAVEFORMS

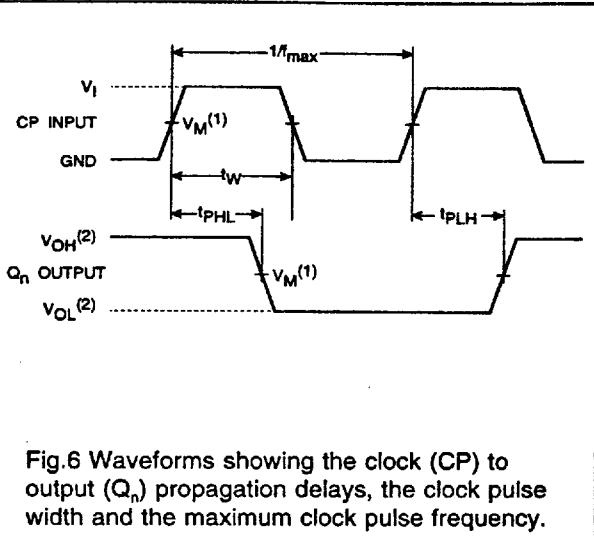


Fig.6 Waveforms showing the clock (CP) to output (Q_n) propagation delays, the clock pulse width and the maximum clock pulse frequency.

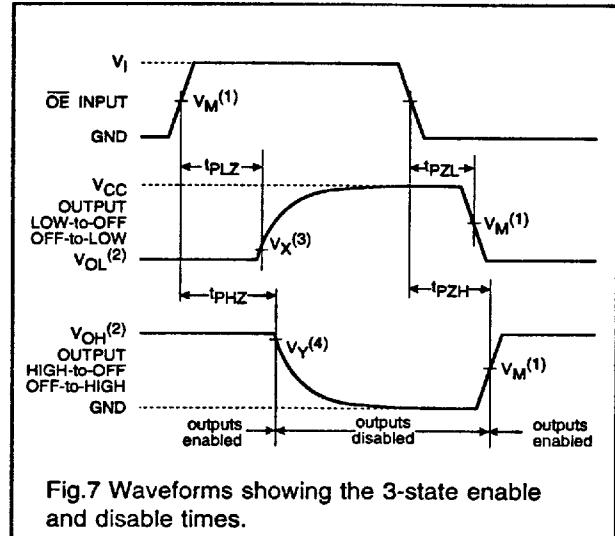


Fig.7 Waveforms showing the 3-state enable and disable times.

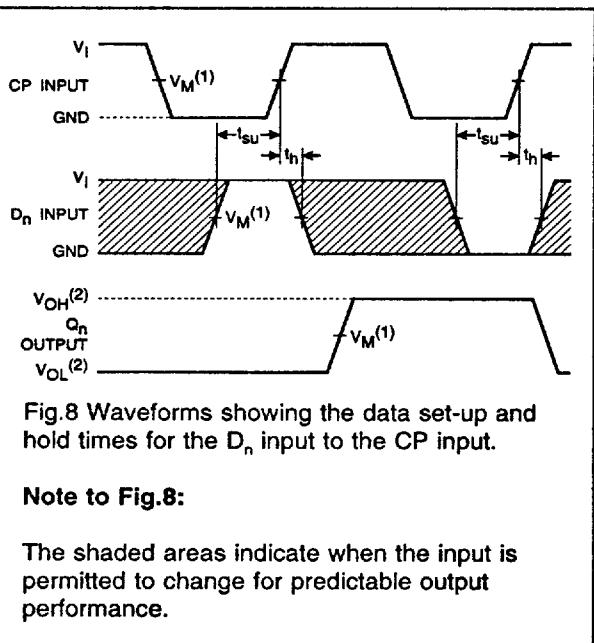
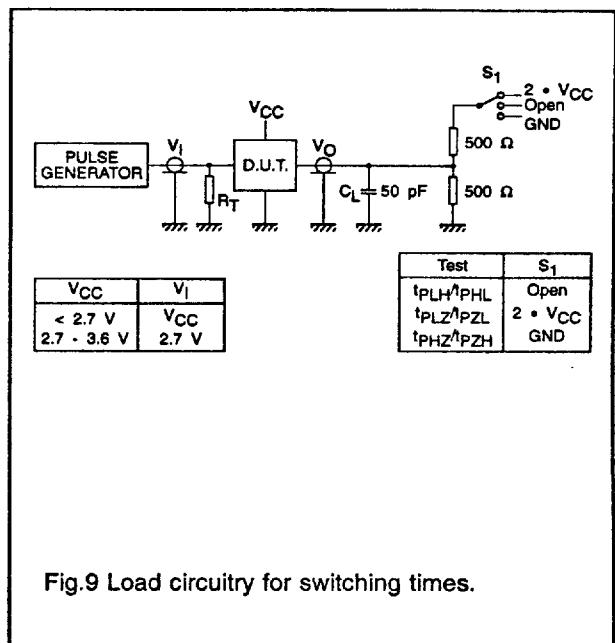


Fig.8 Waveforms showing the data set-up and hold times for the D_n input to the CP input.

Note to Fig.8:

The shaded areas indicate when the input is permitted to change for predictable output performance.



- Notes:
- (1) $V_M = 1.5 \text{ V}$ at $V_{CC} \geq 2.7 \text{ V}$
 $V_M = 0.5 \cdot V_{CC}$ at $V_{CC} < 2.7 \text{ V}$
 - (2) V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load
 - (3) $V_X = V_{OL} + 0.3 \text{ V}$ at $V_{CC} \geq 2.7 \text{ V}$
 $V_X = V_{OL} + 0.1 \cdot V_{CC}$ at $V_{CC} < 2.7 \text{ V}$
 - (4) $V_Y = V_{OH} - 0.3 \text{ V}$ at $V_{CC} \geq 2.7 \text{ V}$
 $V_Y = V_{OH} - 0.1 \cdot V_{CC}$ at $V_{CC} < 2.7 \text{ V}$